

OptiMOS™3 Power-MOSFET

Features

- Fast switching MOSFET for SMPS
- Optimized technology for DC/DC converters
- Qualified according to JEDEC¹⁾ for target applications
- N-channel; Logic level
- Excellent gate charge x R_{DS(on)} product (FOM)
- Very low on-resistance R_{DS(on)}
- Superior thermal resistance
- · Avalanche rated
- Pb-free plating; RoHS compliant
- Halogen-free according to IEC61249-2-21

Туре	Package	Marking
BSC042N03LS G	PG-TDSON-8	042N03LS

Product Summary

V _{DS}	30	٧
$R_{\mathrm{DS(on),max}}$	4.2	mΩ
I _D	93	Α

PG-TDSON-8









Maximum ratings, at T_i =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I _D	V _{GS} =10 V, T _C =25 °C	93	А
		V _{GS} =10 V, T _C =100 °C	59	
		V _{GS} =4.5 V, T _C =25 °C	75	
		V _{GS} =4.5 V, T _C =100 °C	48	
		$V_{\rm GS}$ =10 V, $T_{\rm A}$ =25 °C, $R_{\rm thJA}$ =50 K/W ²⁾	20	
Pulsed drain current ³⁾	I _{D,pulse}	T _C =25 °C	372	
Avalanche current, single pulse ⁴⁾	IAS	T _C =25 °C	50	
Avalanche energy, single pulse	E _{AS}	I_{D} =40 A, R_{GS} =25 Ω	50	mJ
Reverse diode dv/dt	dv/dt	$I_{\rm D}$ =50 A, $V_{\rm DS}$ =24 V, d <i>i</i> /d <i>t</i> =200 A/ μ s, $T_{\rm j,max}$ =150 °C	6	kV/μs
Gate source voltage	V_{GS}		±20	V

¹⁾ J-STD20 and JESD22



Maximum ratings, at T_i =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Power dissipation	P_{tot}	T _C =25 °C	57	W
		T _A =25 °C, R _{thJA} =50 K/W ²⁾	2.5	
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$		-55 150	°C
IEC climatic category; DIN IEC 68-1			55/150/56	

Parameter	Symbol	Conditions		Values		Unit
			min.	typ.	max.	

Thermal characteristics

Thermal resistance, junction - case	R_{thJC}	bottom	-	-	2.2	K/W
		top		-	18	
Device on PCB	R_{thJA}	6 cm ² cooling area ²⁾	-	-	50	

Electrical characteristics, at T_j =25 °C, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	V _{(BR)DSS}	V _{GS} =0 V, I _D =1 mA	30	-	-	V
Gate threshold voltage	$V_{\rm GS(th)}$	$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = 250 \ \mu {\rm A}$	1	-	2.2	
Zero gate voltage drain current	I _{DSS}	$V_{\rm DS} = 30 \text{ V}, V_{\rm GS} = 0 \text{ V}, $ $T_{\rm j} = 25 \text{ °C}$	1	0.1	1	μΑ
		$V_{\rm DS}$ =30 V, $V_{\rm GS}$ =0 V, $T_{\rm j}$ =125 °C	-	10	100	
Gate-source leakage current	I _{GSS}	$V_{\rm GS}$ =20 V, $V_{\rm DS}$ =0 V	1	10	100	nA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} =4.5 V, I _D =30 A	1	5.2	6.5	mΩ
		V _{GS} =10 V, I _D =30 A	-	3.5	4.2	
Gate resistance	R _G		0.7	1.5	2.6	Ω
Transconductance	$oldsymbol{g}_{fs}$	$ V_{\rm DS} > 2 I_{\rm D} R_{\rm DS(on)max},$ $I_{\rm D} = 30~{\rm A}$	42	83	-	s

 $^{^{2)}}$ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm2 (one layer, 70 μ m thick) copper area for drain connection. PCB is vertical in still air.

³⁾ See figure 3 for more detailed information



Parameter	Symbol	Conditions		Values		Uni
			min.	typ.	max.	
Dynamic characteristics						
Input capacitance	C _{iss}		-	2600	3500	pF
Output capacitance	Coss	V _{GS} =0 V, V _{DS} =15 V, f=1 MHz	-	930	1200	
Reverse transfer capacitance	C _{rss}		-	49	-	
Turn-on delay time	t _{d(on)}		-	6.0	-	ns
Rise time	t _r	V _{DD} =15 V, V _{GS} =10 V,	-	4.4	-	
Turn-off delay time	$t_{d(off)}$	$I_{\rm D}$ =30 A, $R_{\rm G,ext}$ =1.6 Ω	-	24	-	
Fall time	t _f]	-	4.0	-	
Gate Charge Characteristics ⁵⁾						
Gate to source charge	Q _{gs}		-	7.4	9.9	nC
Gate charge at threshold	Q _{g(th)}		-	3.9	5.1	- - -
Gate to drain charge	Q _{gd}	V _{DD} =15 V, I _D =30 A,	-	3.5	5.8	
Switching charge	Q _{sw}	V _{GS} =0 to 4.5 V	-	7.0	9.9	
Gate charge total	Qg	1	-	15	20	
Gate plateau voltage	V _{plateau}		-	3.1	-	٧
Gate charge total	Qg	$V_{\rm DD}$ =15 V, $I_{\rm D}$ =30 A, $V_{\rm GS}$ =0 to 10 V	-	31	42	
Gate charge total, sync. FET	Q _{g(sync)}	V _{DS} =0.1 V, V _{GS} =0 to 4.5 V	-	13	17	nC
Output charge	Q _{oss}	V _{DD} =15 V, V _{GS} =0 V	-	24	32	
Reverse Diode	,					-
Diode continuous forward current	Is	T -25 °C	-	-	52	Α
Diode pulse current	I _{S,pulse}	-T _C =25 °C	-	-	372	
Diode forward voltage	V_{SD}	V _{GS} =0 V, I _F =30 A, T _j =25 °C	-	0.84	1.1	V
Reverse recovery charge	Q _{rr}	V_{R} =15 V, I_{F} = I_{S} , di_{F} / dt =400 A/ μ s	-	-	15	nC

⁴⁾ See figure 13 for more detailed information5) See figure 16 for gate charge parameter definition

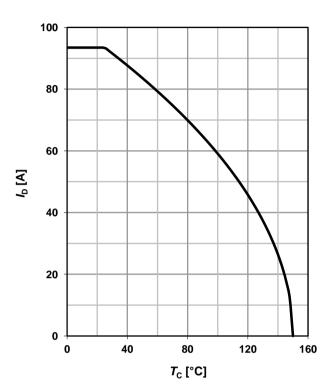


1 Power dissipation

$P_{\text{tot}} = f(T_{\text{C}})$

50 40 20 10 0 0 40 80 120 160 T_C [°C]

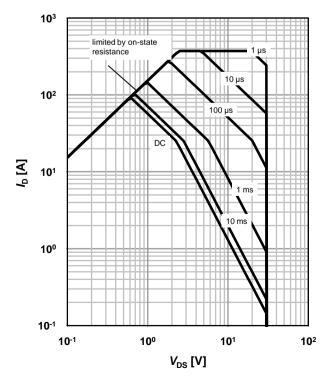
2 Drain current



3 Safe operating area

 $I_D=f(V_{DS}); T_C=25 \text{ °C}; D=0$

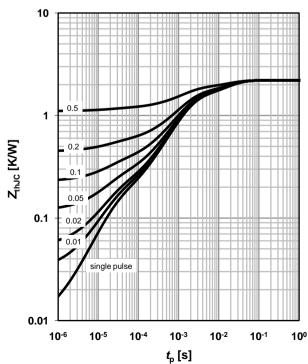
parameter: t_p



4 Max. transient thermal impedance

 Z_{thJC} =f(t_{p})

parameter: $D=t_p/T$

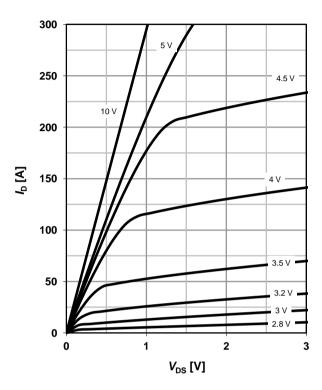




5 Typ. output characteristics

 $I_D=f(V_{DS}); T_i=25 °C$

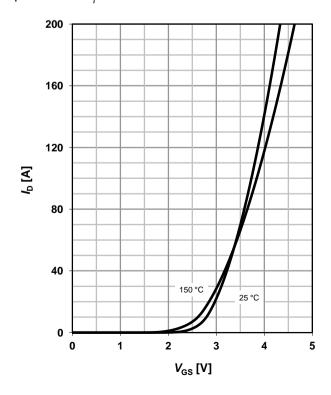
parameter: V_{GS}



7 Typ. transfer characteristics

 $I_{D}=f(V_{GS}); |V_{DS}|>2|I_{D}|R_{DS(on)max}$

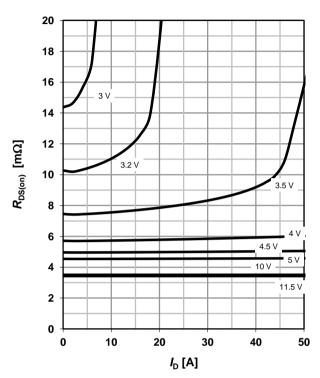
parameter: T_i



6 Typ. drain-source on resistance

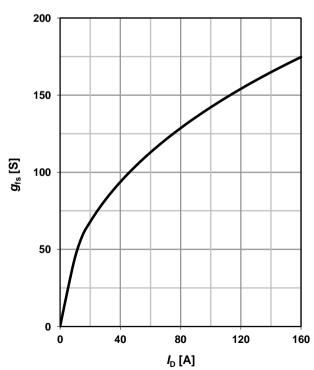
 $R_{DS(on)}=f(I_D); T_j=25 °C$

parameter: V_{GS}



8 Typ. forward transconductance

$$g_{fs}$$
=f(I_D); T_j =25 °C



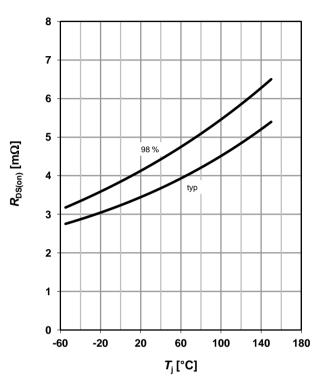


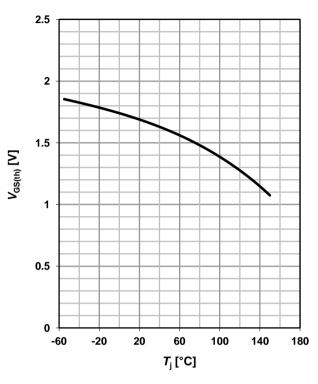
9 Drain-source on-state resistance

 $R_{DS(on)} = f(T_i); I_D = 30 \text{ A}; V_{GS} = 10 \text{ V}$

10 Typ. gate threshold voltage

 $V_{GS(th)}=f(T_i); V_{GS}=V_{DS}; I_D=250 \mu A$





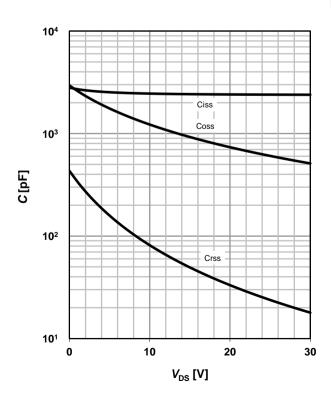
11 Typ. capacitances

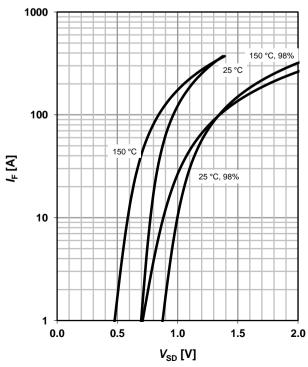
 $C=f(V_{DS}); V_{GS}=0 V; f=1 MHz$

12 Forward characteristics of reverse diode

 $I_{\mathsf{F}} = \mathsf{f}(V_{\mathsf{SD}})$

parameter: $T_{\rm j}$







13 Avalanche characteristics

 $I_{AS}=f(t_{AV}); R_{GS}=25 \Omega$

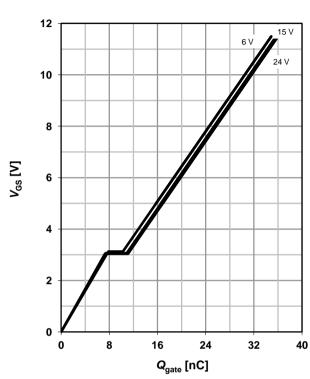
parameter: $T_{j(start)}$

100 25 °C 100 °C 125 °C 1000 °C 1000 °C 1000 t_{AV} [µs]

14 Typ. gate charge

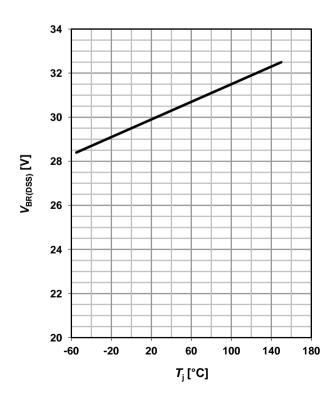
 V_{GS} =f(Q_{gate}); I_D =30 A pulsed

parameter: $V_{\rm DD}$

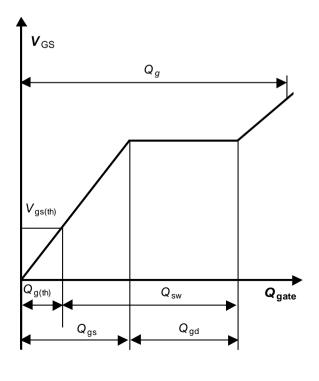


15 Drain-source breakdown voltage

 $V_{BR(DSS)}=f(T_j); I_D=1 \text{ mA}$



16 Gate charge waveforms

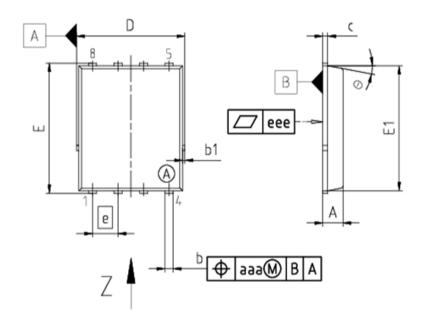


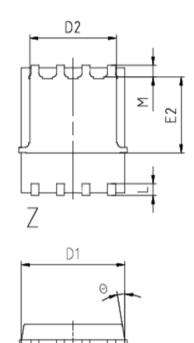


Package Outline

PG-TDSON-8

PG-TDSON-8: Outline





DIM	MILLIM	ETERS			
DIM	MIN	MAX			
Α	0.90	1.10			
b	0.31	0.54			
b1	0.02	0.22			
С	0.15	0.35			
D	5.15	5.49			
D1	4.95	5.35			
D2	3.70	4.40			
E	5.95	6.35			
E1	5.70	6.10			
E2	3.40	3.80			
e	1.	1.27			
N		8			
L	0.45	0.71			
M	0.45	0.75			
Θ	8.5° 12°				
aaa	0.25				
eee	0.08				

DOCUMENT NO.
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EUROPEAN PROJECTION
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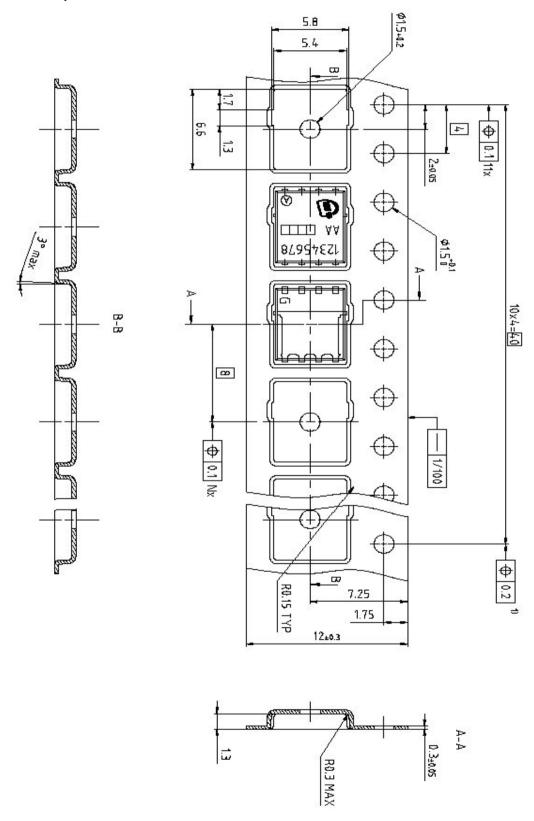
Footprint

Dimensions in mm



Package Outline

PG-TDSON-8: Tape



Dimensions in mm



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